

<b>Notice of References Cited</b>	Application/Control No. 10/553,890		Applicant(s)/Patent Under Reexamination BIAN, LONGXIANG	
	Examiner Seung H. Lee		Art Unit 2876	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,591,956	01-1997	Longacre et al.	235/462.1
*	B	US-5,591,952	01-1997	Krichever et al.	235/462.11
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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